Semiconductor Device Type: Q2AE (S9X) 008 TDFN-S 6x8x0.8mm Matte Tin				Termination Base Alloy: Copper Alloy (Cu)			Package Homogeneous Materials: 8.1 Electronics (e.g. pc boards, displays)			
Connection Device Type.		"Contained In"	% Total							
Basic Substance	CAS Number	Sub-Component	Weight	mg/part	ppm	52.55	(mg) Total	Mold Compound	% ot Total Weight	37.14
Fused Silica	60676-86-0	Mold Compound	32.869	46.509	328,689		Fused Silica	60676-86-0	88.50	
Epoxy Resin 1	Trade Secret	Mold Compound	2.414	3.416	24,141		Epoxy Resin	Trade Secret	6.50	
Phenol Resin	Trade Secret	Mold Compound	1.764	2.496	17,642		Phenol Resin	Trade Secret	4.75	
Carbon Black	1333-86-4	Mold Compound	0.093	0.131	929		Carbon Black	1333-86-4	0.25	
Copper	7440-50-8	Lead Frame	47.490	67.199	474,904			Total	100.00	
Silver	7440-22-4	Lead Frame	3.287	4.651	32,867	73.82	(mg) Total	Lead Frame	% of Total Weight	52.17
Iron	7439-89-6	Lead Frame	1.143	1.617	11,425		Copper	7440-50-8	91.03	
Zinc	7440-66-6	Lead Frame	0.177	0.251	1,774		Silver	7440-22-4	6.30	
Phosphorus	7723-14-0	Lead Frame	0.073	0.103	730		Iron	7439-89-6	2.19	
Silver	7440-22-4	Die Attach	0.963	1.362	9,625		Zinc	7440-66-6	0.34	
Acrylic Resin	Trade secret	Die Attach	0.106	0.150	1,063		Phosphorus	7723-14-0	0.14	
Polybutadiene derivative & copolymer	Trade secret	Die Attach	0.081	0.115	813	-		Total	100.00	
Acrylate	Trade secret	Die Attach	0.069	0.097	688	1.77	(mg) Total	Die Attach	% of Total Weight	1.25
Epoxy Resin 2	Trade secret	Die Attach	0.031	0.044	313		Silver	7440-22-4	77.00	
Silicon	7440-21-3	Chip (Die)	7.800	11.037	78,000	ľ	Acrylic Resin	Trade secret	8.50	
Gold	7440-57-5	Wire Bond	0.040	0.057	400	Polvbutadie	ne derivative & copolymer	r Trade secret	6.50	
Tin	7440-31-5	Plating on external leads (pins) - Matte Tin / annealed at 150°C for 1 hour	1.600	2.264	16.000	Γ	Acrylate	Trade secret	5.50	
	1	TOTALS:		141.500	1.000.000		Epoxy Resin	Trade secret	2.50	
	0 1/15	g Total Mass			,,	E		Total	100.00	
Id 2002/53/EC (End-of-Life Vehicles (ELV) without exemption (zero) ompliance with the above EU Directives has been verified via internal design controls, supplier declarations, and /or analytical test data. a chemical substance is absent from the list above, the chemical substance is NOT an intentional ingredient in the semiconductor device and, to the best of Microchip Technology						11.04	Total (mg)	Chip (Die)	% of Total Weight	7.8
pliance with the above EU Directives has been verified via inter	nal design contro		best of Microo	hip Technolog	y	11.04	Total (mg) Doped Silicon	Chip (Die) 7440-21-3 Total	% of Total Weight 100.00 100.00	7.8
pliance with the above EU Directives has been verified via inter hemical substance is absent from the list above, the chemical s porated's knowledge and belief as of the date of this document with threshold of regulatory concern for any regulatory schem ing compounds used by Microchip meet the UL94 V0 flammabil	nal design contro substance is NOT t, there is no credi e world-wide. lity standard for p	an intentional ingredient in the semiconductor device and, to the ble reason to believe that the unavoidable impurity concentratio	n of the chemic	al substance,		0.06		7440-21-3	100.00	0.04
mpliance with the above EU Directives has been verified via inter- chemical substance is absent from the list above, the chemical s orporated's knowledge and belief as of the date of this document ow the threshold of regulatory concern for any regulatory schem- lding compounds used by Microchip meet the UL94 V0 flammabil p://ul.com/global/eng/pages/offerings/industries/chemicals/plastic e protective "tubes" in which the specific product is shipped are i	nal design contro substance is NOT t, there is no credi e world-wide. lity standard for p cs/	an intentional ingredient in the semiconductor device and, to the ble reason to believe that the unavoidable impurity concentratio lastics. You can access the UL iQTM family of databases to obta	n of the chemic in a test report	al substance,	f any, is not	I	Doped Silicon	7440-21-3 Total Wire Bond 7440-57-5	100.00 100.00 % of Total Weight 100.00	
mpliance with the above EU Directives has been verified via inter- in chemical substance is absent from the list above, the chemical substance is absent from the list above, the chemical substance is absent from the list above, the chemical substance is absent from the list above, the chemical substance is absent from the list above, the chemical substance is absent from the list above, the chemical substance is absent from the list above, the chemical substance is absent from the treatment of the threshold of regulatory concern for any regulatory scheme is protective "tubes" in which the specific product is shipped are tells" may be made from PVC plastic. crochip Technology Incorporated believes the information in this ginal packing materials is true and correct to the best of its knowl d accuracy of data in this form because it has been compiled base tected from disclosure as trade secrets and some information muthe average weight of these parts and the average weight of antic terials contained within silicon devices (silicon IC) in the finished crochip Technology Incorporated does not provide any warranty, volded by Microchip Technology Incorporated and its subsidiaries for acknowledgement, and invoices.	nal design contro substance is NOT t, there is no credi e world-wide. lity standard for p cs/ made from polyvi form concerning ledge and belief, i ed on the ranges ay not have been ipated significant t parts. express or implie s are contained in to Material Conte	an intentional ingredient in the semiconductor device and, to the ble reason to believe that the unavoidable impurity concentratio lastics. You can access the UL iQTM family of databases to obta nyl chloride (PVC) plastic. "Window envelopes" used to hold the substances restricted by RoHS in Microchip Technology Incorpor so of the date listed in this form. Microchip Technology Incorpor provided in Material Safety Data Sheets provided by raw material provided by subcontract assemblers and raw material suppliers. toxic metals components. These estimates do not include trace d, with respect to the information provided in this declaration. Th Microchip's standard terms and conditions of sale. These are pr nt Declarations and shall not be liable for any damages, direct or	n of the chemic in a test report packing slip or rated's semico ted cannot gus suppliers. Sup Information is levels of dopar ne exclusive, lir novided in Micro indirect, conse	at at n the outer boo nductor device arantee the cor plier informati provided only its, metals, and mited product to cochip's quotati	f any, is not and certain es in their npleteness on is often as estimates I non-metal warranties ons, sales werwise,	I	Doped Silicon (mg) Total	7440-21-3 Total Wire Bond	100.00 100.00 % of Total Weight	
mpliance with the above EU Directives has been verified via inter	nal design contro substance is NOT t, there is no credi e world-wide. lity standard for p cs/ made from polyvi form concerning ledge and belief, a ed on the ranges j ay not have been ipated significant i parts. express or implie s are contained in to Material Conte n the information	an intentional ingredient in the semiconductor device and, to the ble reason to believe that the unavoidable impurity concentratio lastics. You can access the UL iQTM family of databases to obta nyl chloride (PVC) plastic. "Window envelopes" used to hold the substances restricted by RoHS in Microchip Technology Incorpor is of the date listed in this form. Microchip Technology Incorpor provided in Material Safety Data Sheets provided by raw material suppliers. toxic metals components. These estimates do not include trace d, with respect to the information provided in this declaration. The Microchip's standard terms and conditions of sale. These are pr in Declarations and shall not be liable for any damages, direct or in Material Content Declarations (MCD) or independent third part	n of the chemic in a test report packing slip or rated's semico ted cannot gus suppliers. Sup Information is levels of dopar ne exclusive, lir novided in Micro indirect, conse	at at n the outer boo nductor device arantee the cor plier informati provided only its, metals, and mited product to cochip's quotati	f any, is not and certain es in their npleteness on is often as estimates I non-metal warranties ons, sales werwise,	0.06	(mg) Total (mg) Total (mg) Total	7440-21-3 Total Wire Bond 7440-57-5 Total Plating on external leads (pins) - Matte Tin / annealed at 150°C for 1 hour	100.00 100.00 % of Total Weight 100.00 100.00 % of Total Weight	0.04